



Type

Clamp-type Test Probes 0.64 mm system



MICRO-KLEPS

Miniature clamp-type test probe with rotating grip jaws (SMD technology). The insulated shaft can be bent up to 35°. Suitable for very thin wires and densely packed contact points (1.27 mm IC spacing pitch). Connects with MKL... and MAL...

Clamping range
Clamp type

2 mm
rotating grip jaws

PART NO. / Housing color

973972100 ●
973972101 ●



KLEPS 3 ST

Miniature clamp-type test probe with rotating grip jaws. Suitable for very thin wires and densely packed contacts. Connects with MKL... and MAL...

3.5 mm
rotating grip jaws

973592100 ●
973592101 ●

Technical data

Type of termination
Rated voltage
Measurment cat. acc. to IEC61010
Rated current*
Contact resistance

2x pin Ø 0.64 mm
30 VAC / 60 VDC
CAT I
2 A
10 mOhm

Material Specifications

Contact material

grip jaws: spring steel,
pin: brass

Contact surface material
Housing material

grip jaws: tin, pin: nickel
PBT

Environmental conditions

Temperature range

-25 °C to +100 °C

Inflamability class

Housing (basic material)

UL 94 HB

pin Ø 0.64 mm
30 VAC / 60 VDC
CAT I
2 A
10 mOhm

grip jaws: spring steel,
pin: brass

grip jaws: tin, pin: nickel
PBT

-25 °C to +100 °C

UL 94 HB

Drawing

Measurements are shown in millimeters.
Multiply by 0.03937 to convert to inches.

